

# 4V Drive Nch+Pch MOSFET

## SP8M21

**●Structure**

Silicon N-channel MOSFET /  
Silicon P-channel MOSFET

**●Features**

- 1) Low on-resistance.
- 2) Built-in G-S protection diode.
- 3) Small and surface mount package (SOP8).

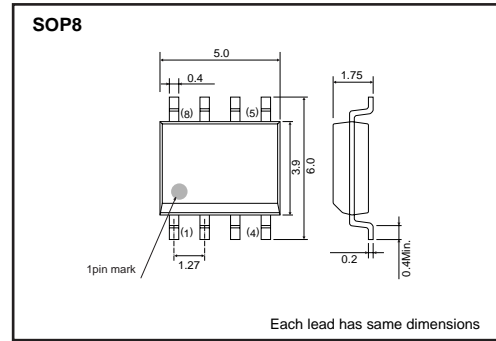
**●Applications**

Switching

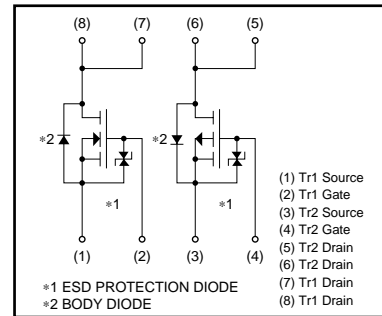
**●Package specifications**

Type	Package	Taping
	Code	TB
	Basic ordering unit (pieces)	2500
SP8M21		○

**●Dimensions (Unit : mm)**



**●Inner circuit**



**●Absolute maximum ratings (Ta=25°C)**

Parameter	Symbol	Limits		Unit
		Tr1 : N-ch	Tr2 : P-ch	
Drain-source voltage	$V_{DSS}$	45	-45	V
Gate-source voltage	$V_{GSS}$	20	-20	V
Drain current	Continuous	$I_D$	$\pm 6.0$	A
	Pulsed	$I_{DP}^{*1}$	$\pm 24$	A
Source current (Body diode)	Continuous	$I_S$	1.0	A
	Pulsed	$I_{SP}^{*1}$	24	A
Total power dissipation	$P_D^{*2}$	2.0		W / TOTAL
		1.4		W / ELEMENT
Channel temperature	$T_{ch}$	150		°C
Storage temperature	$T_{stg}$	-55 to +150		°C

\*1  $P_w \leq 10\mu s$ , Duty cycle  $\leq 1\%$   
\*2 Mounted on a ceramic board.

## Transistors

## N-ch

## ●Electrical characteristics (Ta=25°C)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Conditions
Gate-source leakage	$I_{GSS}$	–	–	10	$\mu A$	$V_{GS}=20V, V_{DS}=0V$
Drain-source breakdown voltage	$V_{(BR)DSS}$	45	–	–	V	$I_D=1mA, V_{GS}=0V$
Zero gate voltage drain current	$I_{DSS}$	–	–	1	$\mu A$	$V_{DS}=45V, V_{GS}=0V$
Gate threshold voltage	$V_{GS(th)}$	1.0	–	2.5	V	$V_{DS}=10V, I_D=1mA$
Static drain-source on-state resistance	$R_{DS(on)}$ *	–	18	25	$m\Omega$	$I_D=6.0A, V_{GS}=10V$
		–	24	34	$m\Omega$	$I_D=6.0A, V_{GS}=4.5V$
		–	26	37	$m\Omega$	$I_D=6.0A, V_{GS}=4.0V$
Forward transfer admittance	$ Y_{fs} $ *	6.0	–	–	S	$V_{DS}=10V, I_D=6.0A$
Input capacitance	$C_{iss}$	–	1400	–	pF	$V_{DS}=10V$
Output capacitance	$C_{oss}$	–	310	–	pF	$V_{GS}=0V$
Reverse transfer capacitance	$C_{rss}$	–	175	–	pF	$f=1MHz$
Turn-on delay time	$t_{d(on)}$ *	–	19	–	ns	$V_{DD}=25V$
Rise time	$t_r$ *	–	30	–	ns	$I_D=3.0A$
Turn-off delay time	$t_{d(off)}$ *	–	72	–	ns	$V_{GS}=10V$
Fall time	$t_f$ *	–	27	–	ns	$R_L=8\Omega$
Total gate charge	$Q_g$ *	–	15.4	21.6	nC	$V_{DD}=25V, V_{GS}=5V$
Gate-source charge	$Q_{gs}$ *	–	3.7	–	nC	$I_D=6.0A$
Gate-drain charge	$Q_{gd}$ *	–	6.5	–	nC	$R_L=4\Omega, R_G=10\Omega$

\*Pulsed

## ●Body diode characteristics (Source-drain) (Ta=25°C)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Conditions
Forward voltage	$V_{SD}$ *	–	–	1.2	V	$I_S=6.0A, V_{GS}=0V$

\*Pulsed

## Transistors

## P-ch

## ●Electrical characteristics (Ta=25°C)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Conditions
Gate-source leakage	$I_{GSS}$	–	–	–10	$\mu A$	$V_{GS} = -20V, V_{DS} = 0V$
Drain-source breakdown voltage	$V_{(BR)DSS}$	–45	–	–	V	$I_D = -1mA, V_{GS} = 0V$
Zero gate voltage drain current	$I_{DSS}$	–	–	–1	$\mu A$	$V_{DS} = -45V, V_{GS} = 0V$
Gate threshold voltage	$V_{GS(th)}$	–1.0	–	–2.5	V	$V_{DS} = -10V, I_D = -1mA$
Static drain-source on-state resistance	$R_{DS(on)}$ *	–	33	46	m $\Omega$	$I_D = -4.0A, V_{GS} = -10V$
		–	43	60	m $\Omega$	$I_D = -4.0A, V_{GS} = -4.5V$
		–	47	65	m $\Omega$	$I_D = -4.0A, V_{GS} = -4.0V$
Forward transfer admittance	$ Y_{fs} $ *	6.0	–	–	S	$V_{DS} = -10V, I_D = -4.0A$
Input capacitance	$C_{iss}$	–	2400	–	pF	$V_{DS} = -10V$
Output capacitance	$C_{oss}$	–	320	–	pF	$V_{GS} = 0V$
Reverse transfer capacitance	$C_{rss}$	–	200	–	pF	$f = 1MHz$
Turn-on delay time	$t_{d(on)}$ *	–	23	–	ns	$V_{DD} = -25V$
Rise time	$t_r$ *	–	23	–	ns	$I_D = -2.0A$
Turn-off delay time	$t_{d(off)}$ *	–	90	–	ns	$V_{GS} = -10V$
Fall time	$t_f$ *	–	22	–	ns	$R_L = 12.5\Omega$
Total gate charge	$Q_g$ *	–	20.0	28.0	nC	$V_{DD} = -25V, V_{GS} = -5V$
Gate-source charge	$Q_{gs}$ *	–	6.5	–	nC	$I_D = -4.0A$
Gate-drain charge	$Q_{gd}$ *	–	7.5	–	nC	$R_L = 6\Omega, R_G = 10\Omega$

\*Pulsed

## ●Body diode characteristics (Source-drain) (Ta=25°C)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Conditions
Forward voltage	$V_{SD}$ *	–	–	–1.2	V	$I_S = -4.0A, V_{GS} = 0V$

\*Pulsed

Transistors

N-ch

●Electrical characteristic curves

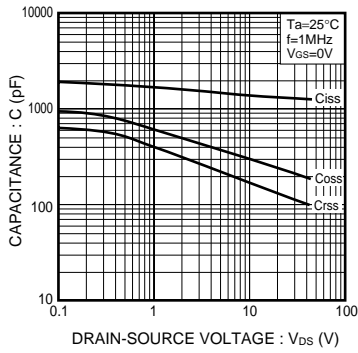


Fig.1 Typical Capacitance vs. Drain-Source Voltage

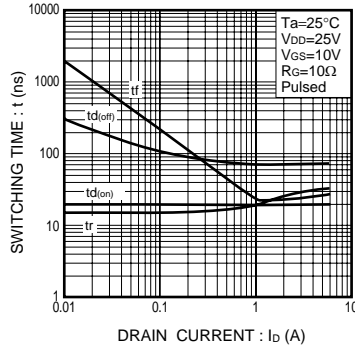


Fig.2 Switching Characteristics

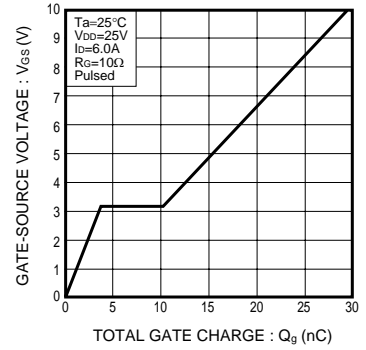


Fig.3 Dynamic Input Characteristics

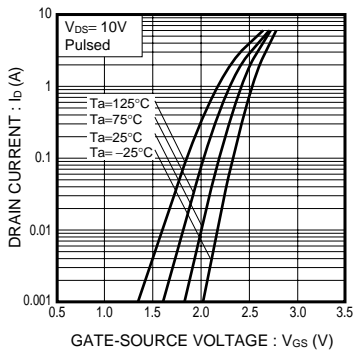


Fig.4 Typical Transfer Characteristics

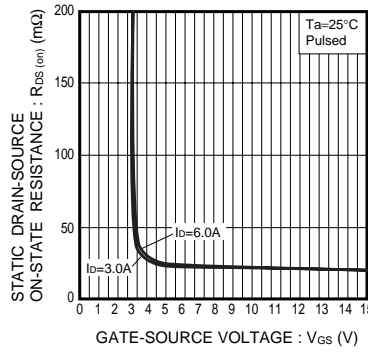


Fig.5 Static Drain-Source On-State Resistance vs. Gate-Source Voltage

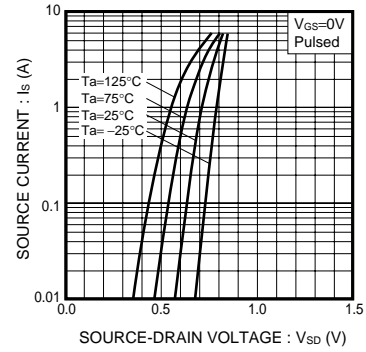


Fig.6 Source Current vs. Source-Drain Voltage

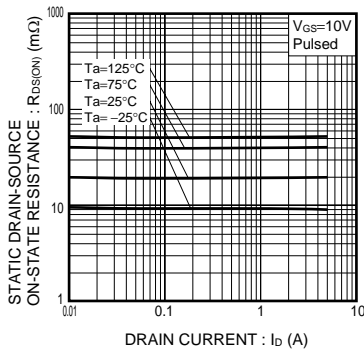


Fig.7 Static Drain-Source On-State Resistance vs. Drain Current ( I )

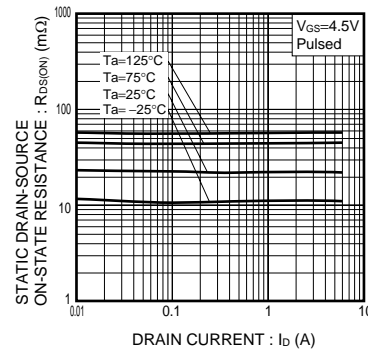


Fig.8 Static Drain-Source On-State Resistance vs. Drain Current ( II )

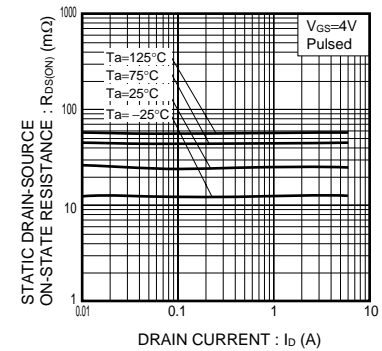


Fig.9 Static Drain-Source On-State Resistance vs. Drain Current ( III )

Transistors

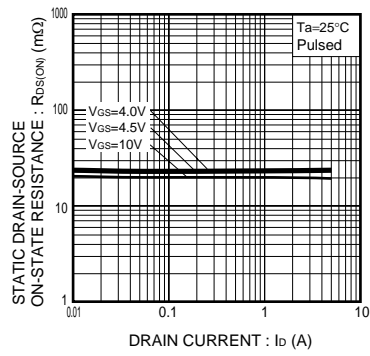


Fig.10 Static Drain-Source On-State Resistance vs. Drain Current (IV)

Transistors

P-ch

●Electrical characteristic curves

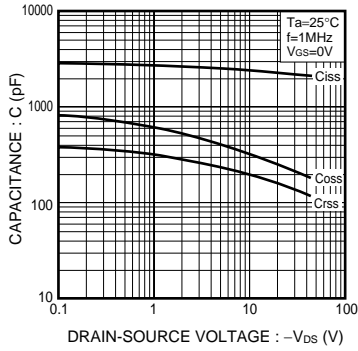


Fig.1 Typical Capacitance vs. Drain-Source Voltage

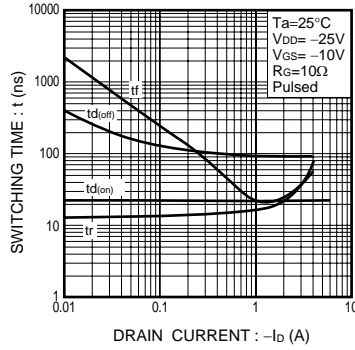


Fig.2 Switching Characteristics

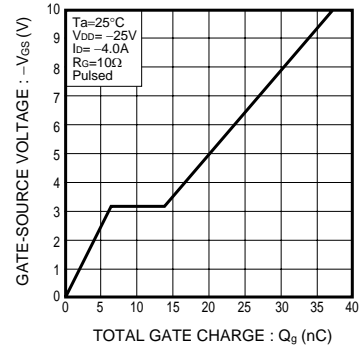


Fig.3 Dynamic Input Characteristics

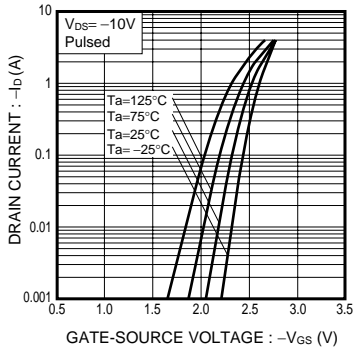


Fig.4 Typical Transfer Characteristics

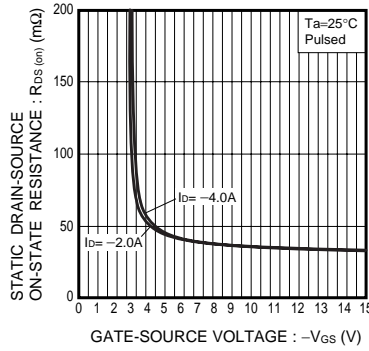


Fig.5 Static Drain-Source On-State Resistance vs. Gate-Source Voltage

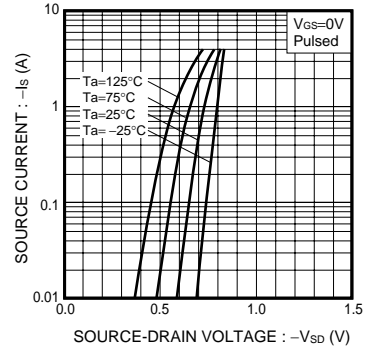


Fig.6 Source Current vs. Source-Drain Voltage

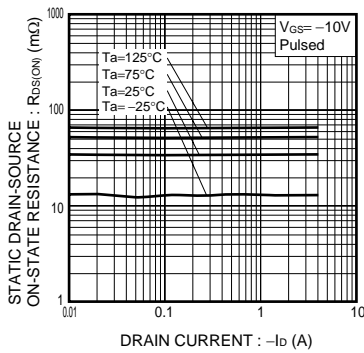


Fig.7 Static Drain-Source On-State Resistance vs. Drain Current ( I )

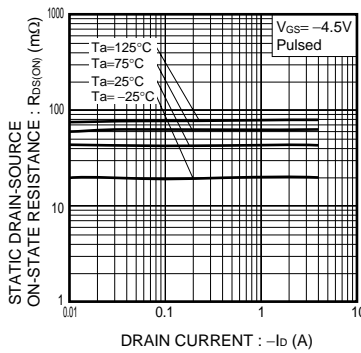


Fig.8 Static Drain-Source On-State Resistance vs. Drain Current ( II )

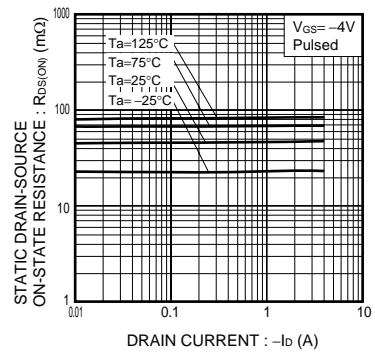


Fig.9 Static Drain-Source On-State Resistance vs. Drain Current ( III )

Transistors

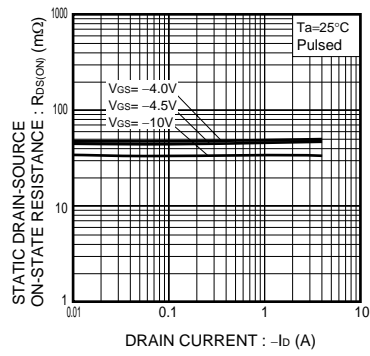


Fig.10 Static Drain-Source On-State Resistance vs. Drain Current (IV)

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